Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/632,386	STEERE ET AL.	
Examiner	Art Unit	
Tuan V. Thai	2186	

	SEARCHED				
Class	Subclass	Date	Examiner		
711	100	3/12/2006	тн		
711	117	3/12/2006	тн		
711 <	133	3/12/2006	ТН		
711	134	3/12/2006	тн		
711	135	3/12/2006	тн		
711	154	3/12/2006	TH		
707	100	3/12/2006	тн		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

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	DATE	EXMR
EAST updated searches: USPGPUB DERWENTs EPO/JPO abstract		
IBMTDB		
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